

### General Description

- Trench Power MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

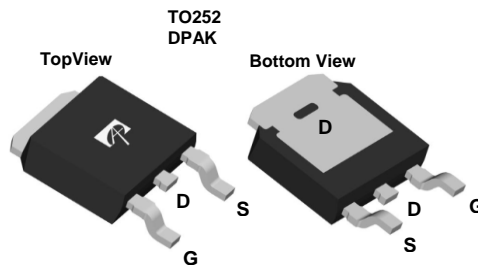
### Applications

- DC/DC Converters in Computing
- Suitable for general purpose

### Product Summary

|                                  |                 |
|----------------------------------|-----------------|
| $V_{DS}$                         | 30V             |
| $I_D$ (at $V_{GS}=10V$ )         | 70A             |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 3.4m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 4.5m $\Omega$ |

100% UIS Tested  
 100% Rg Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOD32324              | TO-252       | Tape & Reel | 2500                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$       | 30                      | V                |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$                | V                |
| Continuous Drain Current <sup>G</sup>  | $I_D$          | $T_C=25^\circ\text{C}$  | 70               |
|  |                | $T_C=100^\circ\text{C}$ |                  |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 245                     | A                |
| Continuous Drain Current               | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | 33               |
|  |                | $T_A=70^\circ\text{C}$  | 27               |
| Avalanche Current <sup>C</sup>         | $I_{AS}$       | 53                      | A                |
| Avalanche energy                       | $E_{AS}$       | 140                     | mJ               |
| Power Dissipation <sup>B</sup>         | $P_D$          | $T_C=25^\circ\text{C}$  | 69               |
|  |                | $T_C=100^\circ\text{C}$ | 27               |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 6.2              |
|  |                | $T_A=70^\circ\text{C}$  | 4                |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 15           | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | Steady-State | 40  | 50                 |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 1.5          | 1.8 | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions   | Min                                | Typ  | Max    | Units |
|-----------------------------|--|--|------------------------------------|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |  |  |                                    |      |        |       |
| B <sub>V</sub> DSS          | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30                                 |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |                                    |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V   |                                    |      | ±100   | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1.3                                | 1.8  | 2.3    | V     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |                                    | 2.8  | 3.4    | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   |                                    | 4.3  | 5.2    |       |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |                                    | 85   |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |                                    | 0.7  | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>6</sup> |  |                                    |      | 70     | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |  |                                    |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  |                                    | 5350 |        | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |  |                                    | 400  |        | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance                       |  |                                    | 290  |        | pF    |
| R <sub>g</sub>              | Gate resistance                                    | f=1MHz   | 0.9                                | 1.8  | 2.7    | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |  |                                    |      |        |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            |                                    | 80   | 120    | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                                  |  |                                    | 35   | 55     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |  |                                    | 13   |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |  |                                    | 13   |        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |                                    | 13   |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |  |                                    | 18   |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |  |                                    | 70   |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |  |                                    | 19   |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   |  | I <sub>F</sub> =20A, di/dt=500A/μs |      | 12     |       |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, di/dt=500A/μs   |                                    | 24   |        | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

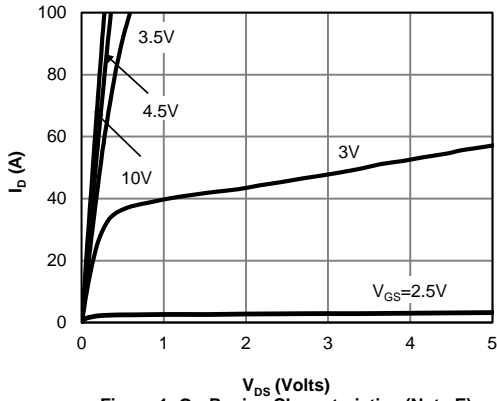


Figure 1: On-Region Characteristics (Note E)

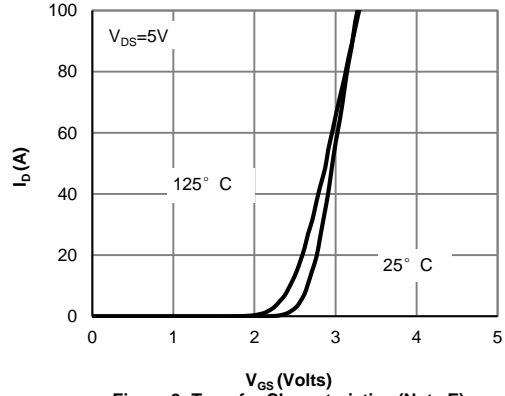


Figure 2: Transfer Characteristics (Note E)

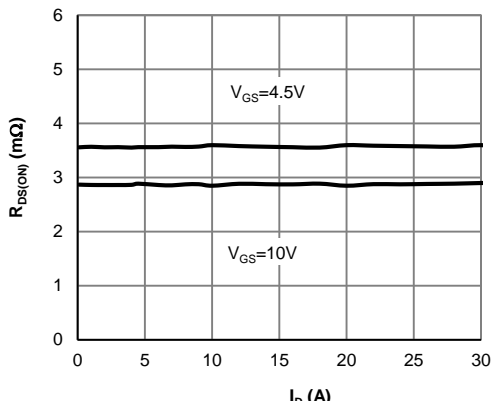


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

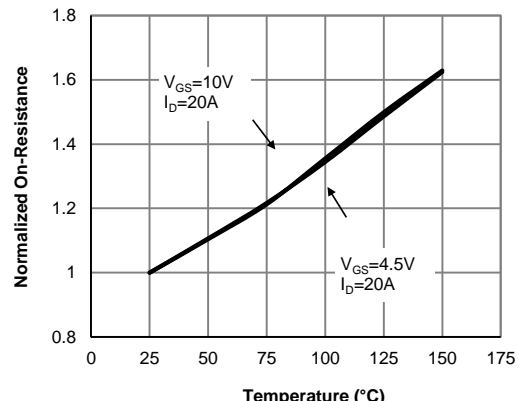


Figure 4: On-Resistance vs. Junction Temperature (Note E)

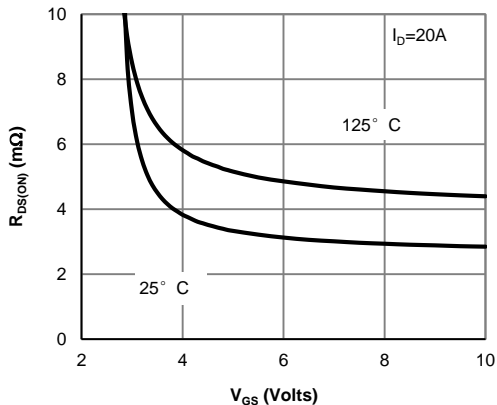


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

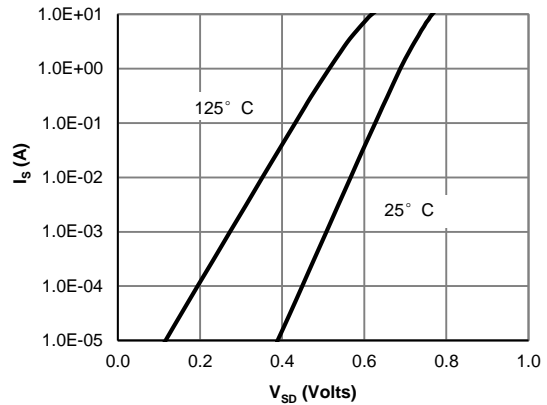


Figure 6: Body-Diode Characteristics (Note E)

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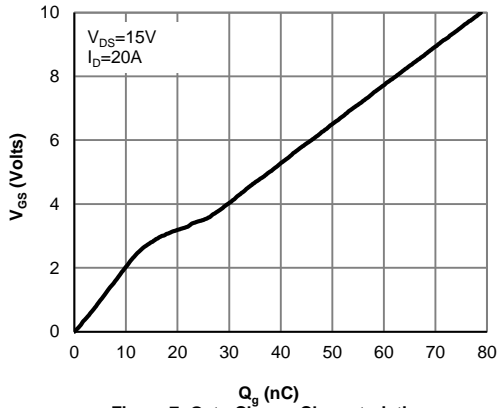


Figure 7: Gate-Charge Characteristics

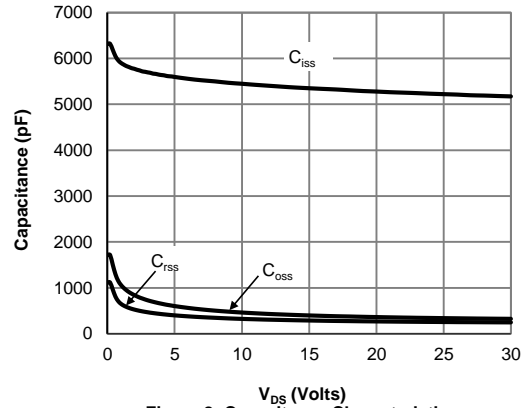


Figure 8: Capacitance Characteristics

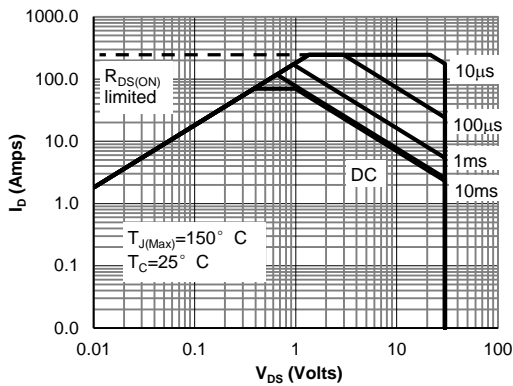


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

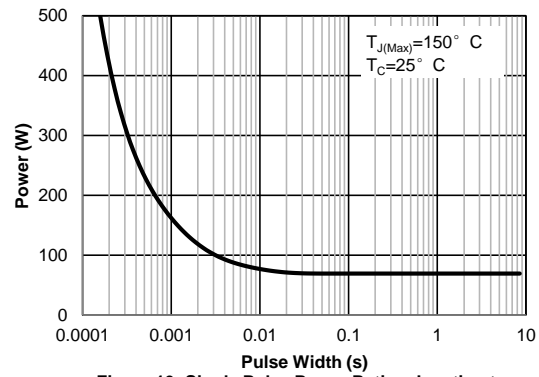


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

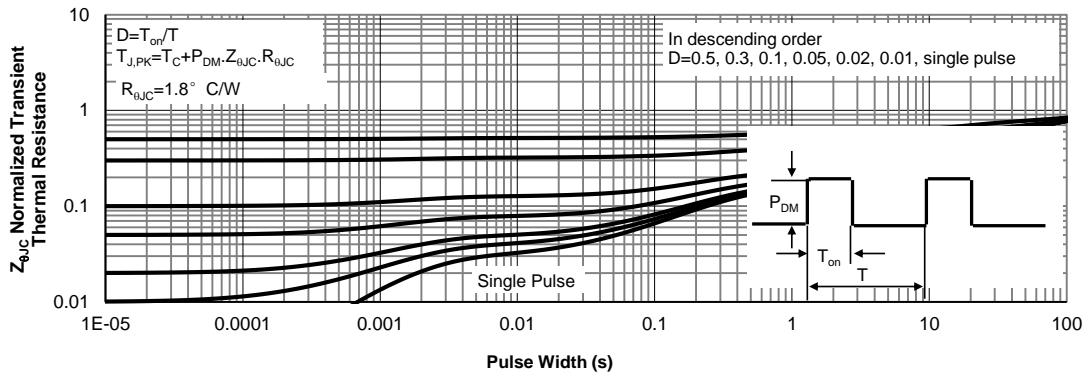


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

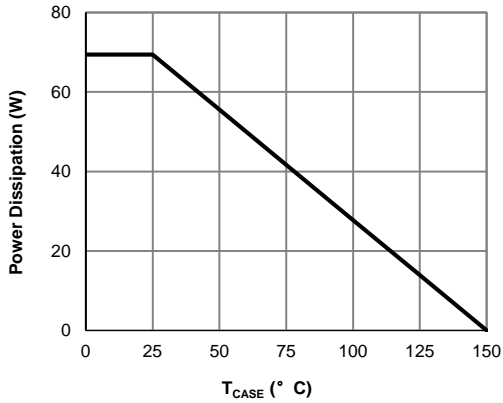


Figure 12: Power De-rating (Note F)

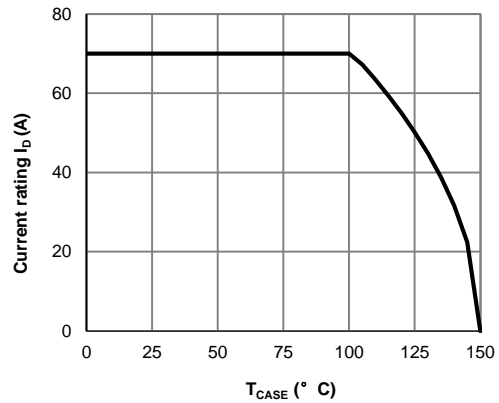


Figure 13: Current De-rating (Note F)

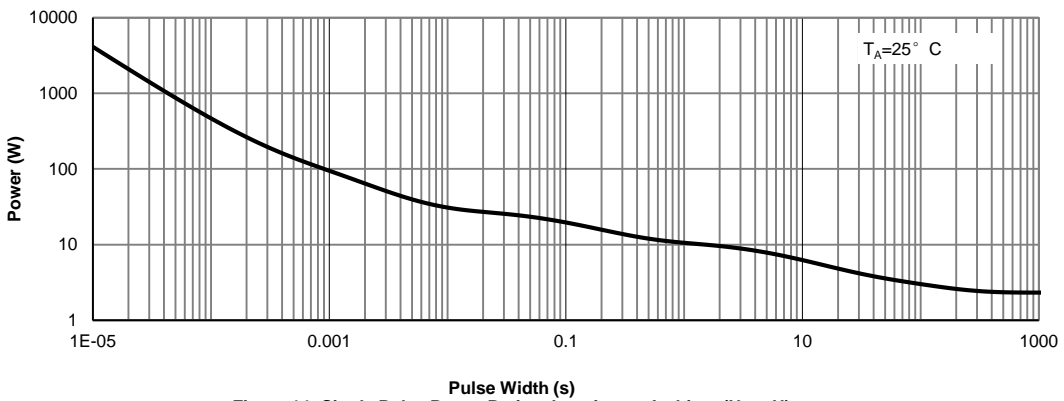


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

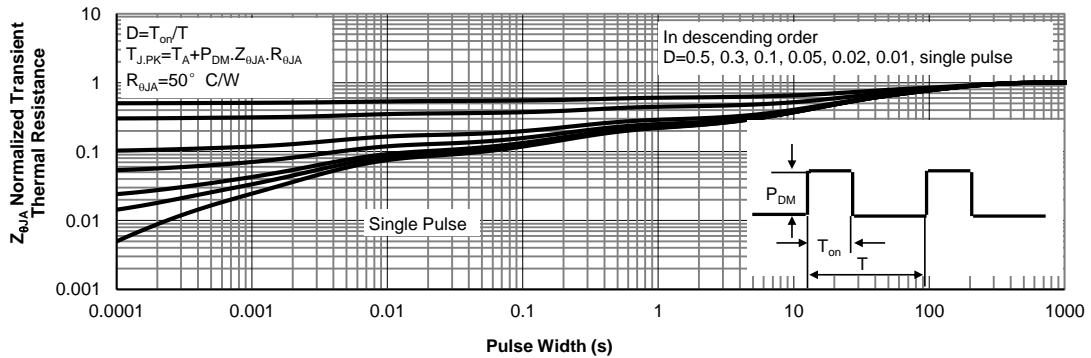


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

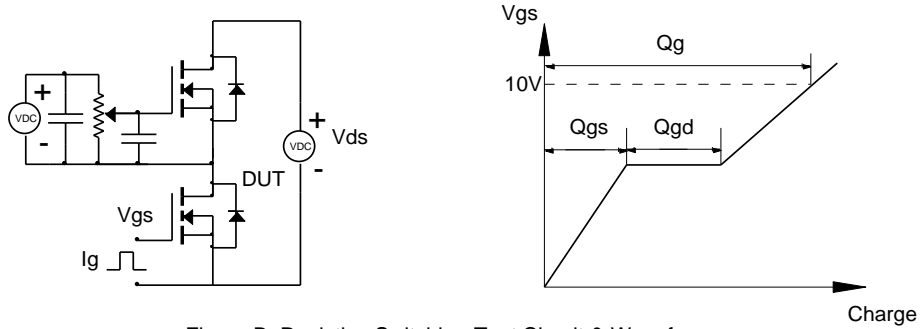


Figure B: Resistive Switching Test Circuit & Waveforms

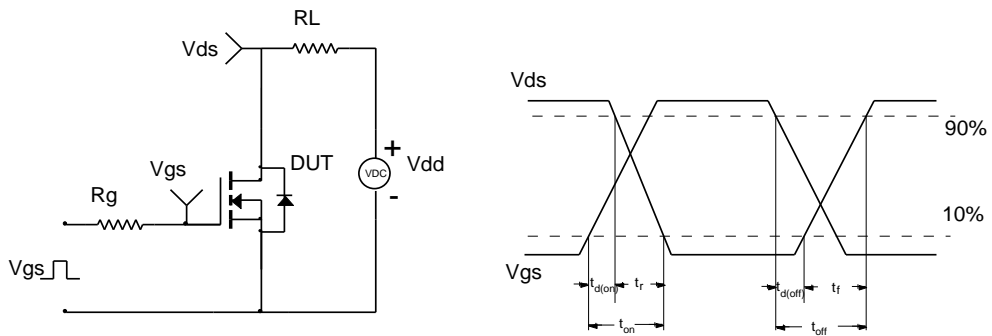


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

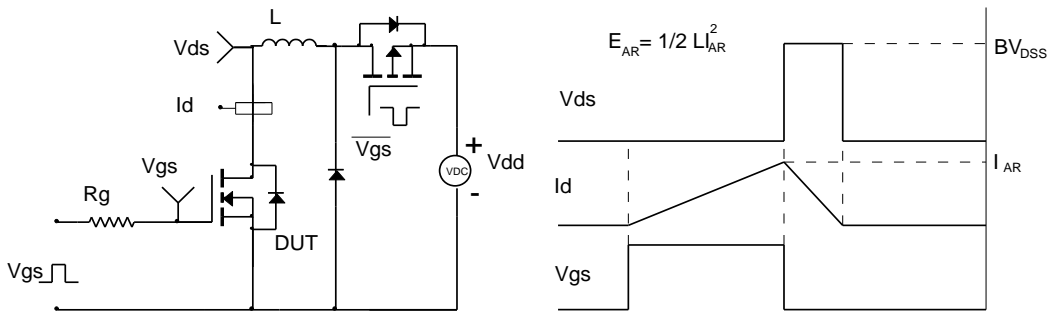
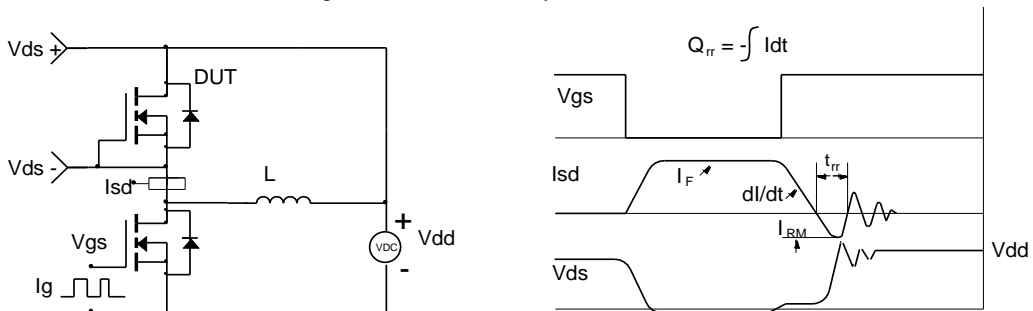


Figure D: Diode Recovery Test Circuit & Waveforms



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